



HCF4033B

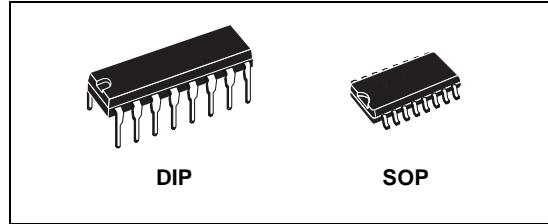
DECADE COUNTER/DIVIDER WITH DECODED 7-SEGMENT DISPLAY OUTPUT AND RIPPLE BLANKING

- COUNTER AND 7-SEGMENT DECODING IN ONE PACKAGE
- EASILY INTERFACED WITH 7-SEGMENT DISPLAY TYPES
- FULLY STATIC COUNTER OPERATION : DC TO 6MHz (Typ.) AT $V_{DD} = 10V$
- IDEAL FOR LOW POWER DISPLAYS
- RIPPLE BLANKING AND LAMP TEST
- QUIESCENT CURRENT SPECIF. UP TO 20V
- STANDARDIZED SYMMETRICAL OUTPUT CHARACTERISTICS
- INPUT LEAKAGE CURRENT
 $I_I = 100nA$ (MAX) AT $V_{DD} = 18V$ $T_A = 25^\circ C$
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC JESD13B " STANDARD SPECIFICATIONS FOR DESCRIPTION OF B SERIES CMOS DEVICES"

DESCRIPTION

The HCF4033B is a monolithic integrated circuit fabricated in Metal Oxide Semiconductor technology available in DIP and SOP packages.

The HCF4033B consists of a 5-stages Johnson decade counter and an output decoder which converts the Johnson code to a 7 segment decoded output for driving one stage in a numerical display. This device is particularly advantageous in display applications where low power dissipation and/or low package count are



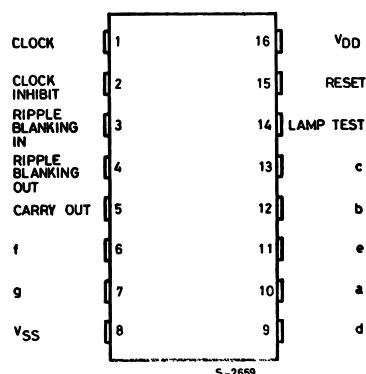
ORDER CODES

PACKAGE	TUBE	T & R
DIP	HCF4033BEY	
SOP	HCF4033BM1	HCF4033M013TR

important. This device has CLOCK, RESET, CLOCK INHIBIT, RIPPLE BLANKING, LAMP TEST input, CARRY OUT, RIPPLE BLANKING and 7 DECODED outputs (a to g).

A high RESET signal clears the decade counter to its zero count. The counter is advanced one count at the positive clock signal transition if the CLOCK INHIBIT signal is low. Counter advancement via the clock line is inhibited when the CLOCK INHIBIT signal is high. Antilock gating is provided on the JOHNSON counter, thus assuring proper counting sequence. The CARRY-OUT (C_{OUT}) signal completes one cycle every ten CLOCK INPUT cycles and is used to clock the succeeding decade directly in a multi-decade counting chain.

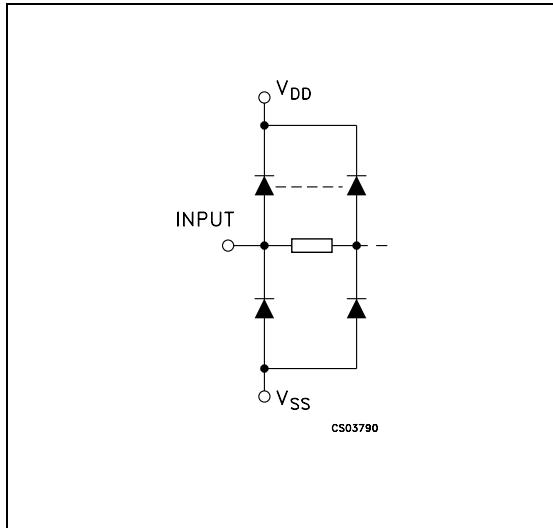
PIN CONNECTION



HCF4033B

The seven decoded outputs (a, b, c, d, e, f, g) illuminate the proper segments in a seven segment display device used for representing the decimal numbers 0 to 9. The 7-segment outputs go high on selection. This device has provisions for automating blanking of the non-significant zeros in a multi digit decimal number which results in a easily readable display consistent with normal writing practice. For example, the number 0050.07000 in an eight digit display would be displayed as 50.07. Zero suppression on the integer side is obtained by connecting the RBI terminal of the HCF4033B associated with the most significant digit in the display to a low level voltage and connecting the RBO terminal of that stage to the RBI terminal of the HCF4033B in the next lower significant position in the display. This procedure is continued for each succeeding HCF4033B on the integer side of the display. On the fraction side of the display the RBI of the

INPUT EQUIVALENT CIRCUIT

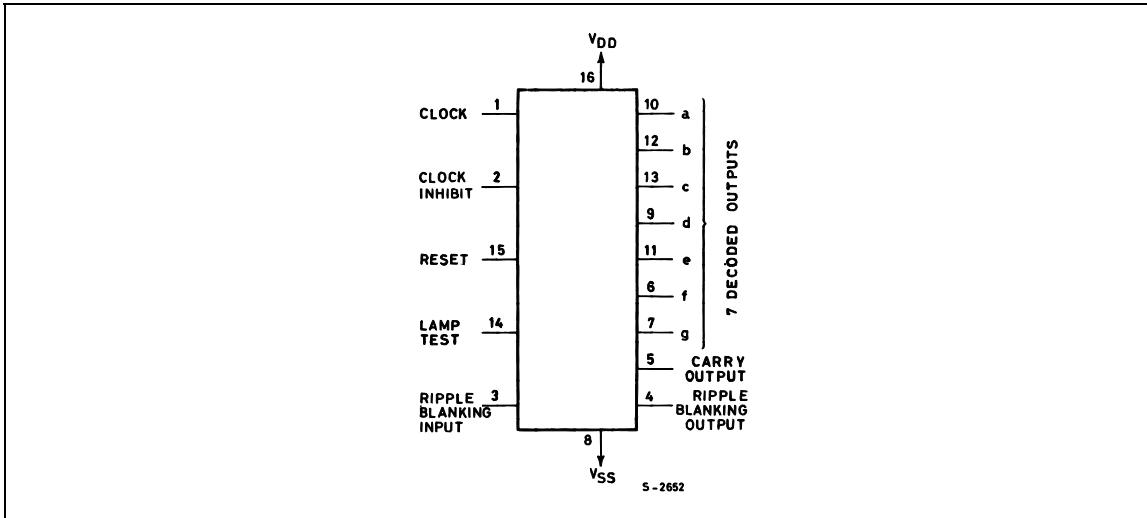


HCF4033B associated with the least significant bit is connected to a low level voltage and the RBO of that HCF4033B is connected to the RBI terminal of the HCF4033B in the next more significant bit position. Again, this procedure is continued for all HCF4033B's on the fraction side of the display. In a purely fractional number the zero immediately preceding the decimal point can be displayed by connecting the RBI of that stage to a high level voltage (instead of to the RBO of the next more significant stage). For example : optional zero $\rightarrow 0.7346$. Likewise, the zero in a number such as 763.0 can be displayed by connecting the RBI of the HCF4033B associated with it to a high level voltage. Ripple blanking of non-significant zeros provides an appreciable savings in display power. The HCF4033B has a LAMP TEST input which, when connected to a high level voltage, overrides normal decoder operation and enables a check to be made on possible display malfunctions by putting the seven outputs in the high state.

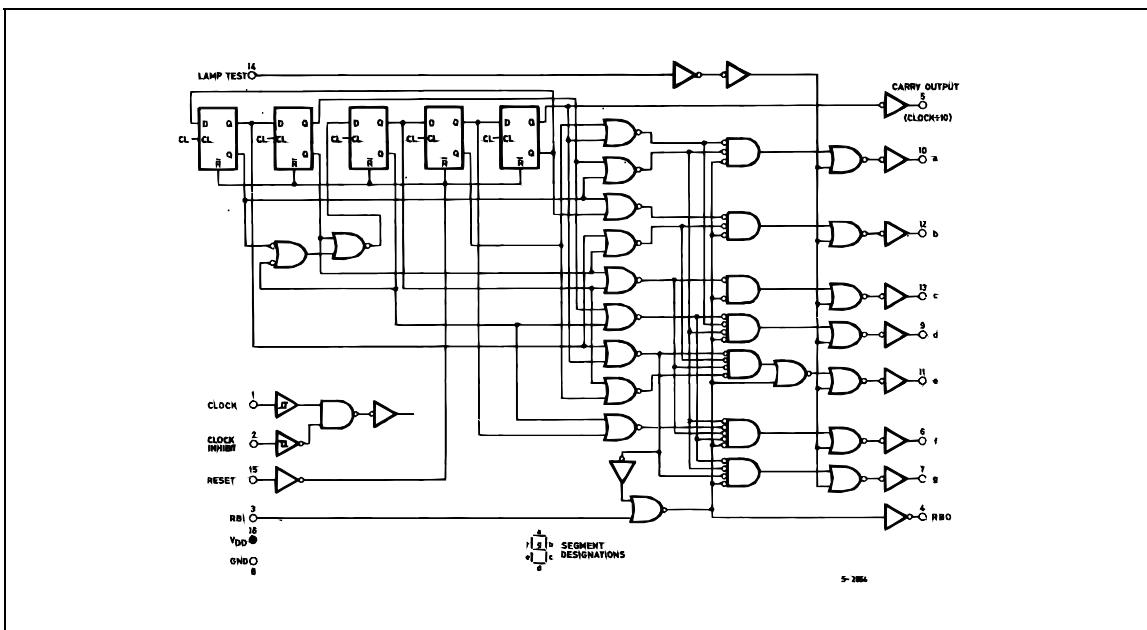
PIN DESCRIPTION

PIN No	SYMBOL	NAME AND FUNCTION
1	CLOCK	Clock Input
10, 12, 13, 9, 11, 6, 7	a to g	7 - Segments Decoded Outputs
2	CLOCK INHIBIT	Clock Inhibit Input
15	RESET	Reset Input
3	RIPPLE BLANKING IN	Ripple Blanking Input
5	CARRY OUT	Carry Out Output
4	RIPPLE BLANKING OUT	Ripple Blanking Output
14	LAMP TEST	Lamp Test Input
8	V_{SS}	Negative Supply Voltage
16	V_{DD}	Positive Supply Voltage

FUNCTIONAL DIAGRAM

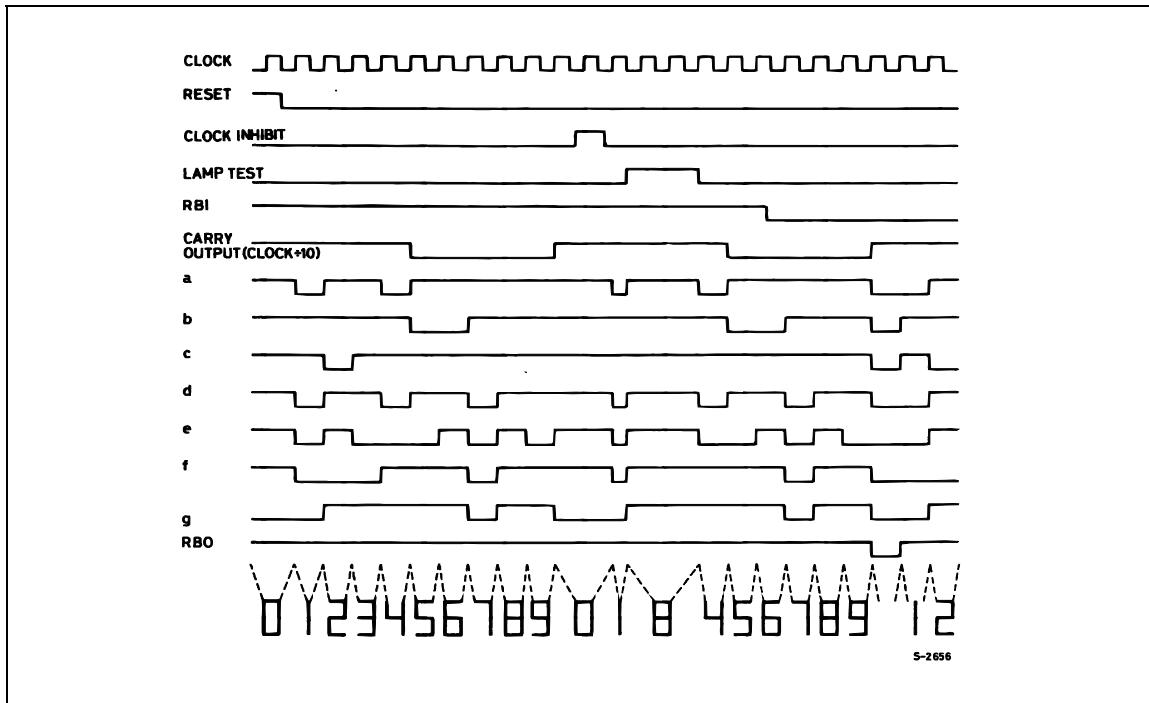


LOGIC DIAGRAM



HCF4033B

TIMING CHART



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{DD}	Supply Voltage	-0.5 to +22	V
V_I	DC Input Voltage	-0.5 to $V_{DD} + 0.5$	V
I_I	DC Input Current	± 10	mA
P_D	Power Dissipation per Package	200	mW
	Power Dissipation per Output Transistor	100	mW
T_{op}	Operating Temperature	-55 to +125	°C
T_{stg}	Storage Temperature	-65 to +150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

All voltage values are referred to V_{SS} pin voltage.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{DD}	Supply Voltage	3 to 20	V
V_I	Input Voltage	0 to V_{DD}	V
T_{op}	Operating Temperature	-55 to 125	°C

DC SPECIFICATIONS

Symbol	Parameter	Test Conditions				Value						Unit	
		V_I (V)	V_O (V)	$ I_O $ (μ A)	V_{DD} (V)	$T_A = 25^\circ C$			$-40 \text{ to } 85^\circ C$		$-55 \text{ to } 125^\circ C$		
						Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
I_L	Quiescent Current	0/5			5		0.04	5		150		150	μ A
		0/10			10		0.04	10		300		300	
		0/15			15		0.04	20		600		600	
		0/20			20		0.08	100		3000		3000	
V_{OH}	High Level Output Voltage	0/5		<1	5	4.95			4.95		4.95		V
		0/10		<1	10	9.95			9.95		9.95		
		0/15		<1	15	14.95			14.95		14.95		
V_{OL}	Low Level Output Voltage	5/0		<1	5		0.05			0.05		0.05	V
		10/0		<1	10		0.05			0.05		0.05	
		15/0		<1	15		0.05			0.05		0.05	
V_{IH}	High Level Input Voltage		0.5/4.5	<1	5	3.5			3.5		3.5		V
			1/9	<1	10	7			7		7		
			1.5/18.5	<1	15	11			11		11		
V_{IL}	Low Level Input Voltage		0.5/4.5	<1	5			1.5		1.5		1.5	V
			9/1	<1	10			3		3		3	
			1.5/18.5	<1	15			4		4		4	
I_{OH}	Output Drive Current	0/5	2.5		5	-1.36	-3.2		-1.1		-1.1		mA
		0/5	4.6		5	-0.44	-1		-0.36		-0.36		
		0/10	9.5		10	-1.1	-2.6		-0.9		-0.9		
		0/15	13.5		15	-3.0	-6.8		-2.4		-2.4		
I_{OL}	Output Sink Current	0/5	0.4		5	0.44	1		0.36		0.36		mA
		0/10	0.5		10	1.1	2.6		0.9		0.9		
		0/15	1.5		15	3.0	6.8		2.4		2.4		
I_I	Input Leakage Current	0/18	any input	18		$\pm 10^{-5}$	± 0.1		± 1		± 1	μ A	
C_I	Input Capacitance		any input			5	7.5					pF	

The Noise Margin for both "1" and "0" level is: 1V min. with $V_{DD}=5V$, 2V min. with $V_{DD}=10V$, 2.5V min. with $V_{DD}=15V$

HCF4033B

DYNAMIC ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^\circ C$, $C_L = 50\text{pF}$, $R_L = 200K\Omega$, $t_r = t_f = 20\text{ ns}$)

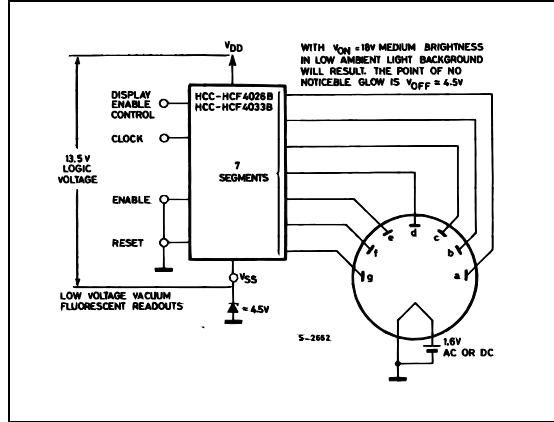
Symbol	Parameter	Test Condition			Value (*)			Unit	
		V_{DD} (V)			Min.	Typ.	Max.		
CLOCKED OPERATION									
t_{PLH} t_{PHL}	Propagation Delay Time (Carry Out Line)	5				250	500	ns	
		10				100	200		
		15				75	150		
t_{PLH} t_{PHL}	Propagation Delay Time (Decoded Out Lines)	5				350	700	ns	
		10				125	250		
		15				90	180		
t_{THL} t_{TLH}	Transition Time (Carry Out Line)	5				100	200	ns	
		10				50	100		
		15				25	50		
f_{CL} ⁽¹⁾	Maximum Clock Input Frequency	5				2.5	5	MHz	
		10				5.5	11		
		15				8	16		
t_{WC}	Clock Pulse Width	5				110	260	ns	
		10				50	100		
		15				40	80		
t_r , t_f	Clock Input Rise or Fall Time	5			Unlimited			μs	
		10			Unlimited				
		15			Unlimited				
RESET OPERATION									
t_{PLH} t_{PHL}	Propagation Delay Time (Carry Out Line)	5				275	550	ns	
		10				120	240		
		15				80	160		
t_{PLH} t_{PHL}	Propagation Delay Time (Decoded Out Lines)	5				300	600	ns	
		10				125	250		
		15				90	180		
t_{WR}	Reset Pulse Width	5				100	120	ns	
		10				50	100		
		15				25	50		
t_{rem}	Reset Removal Time	5				0	30	ns	
		10				0	15		
		15				0	10		

(*) Typical temperature coefficient for all V_{DD} value is 0.3 %/ $^\circ C$.

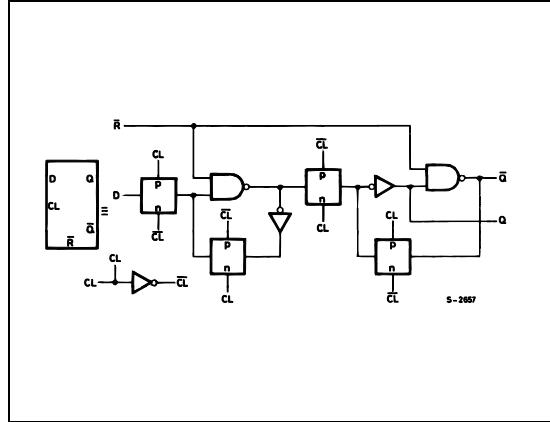
(1) Measured with respect to carry output line.

TYPICAL APPLICATIONS

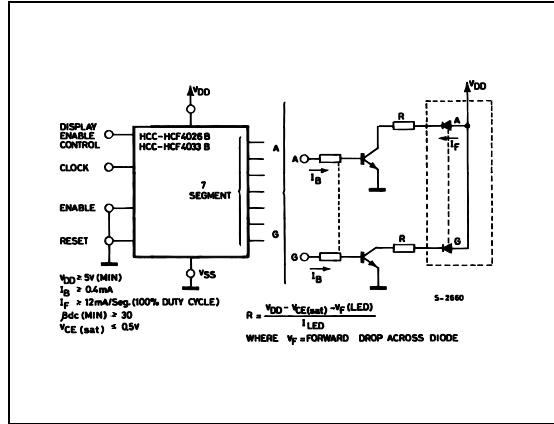
Interfacing with Filament Fluorescent Display



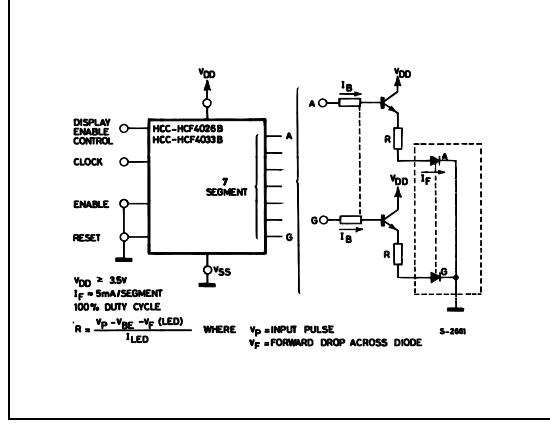
Detail of Typical Flip-flop Stage



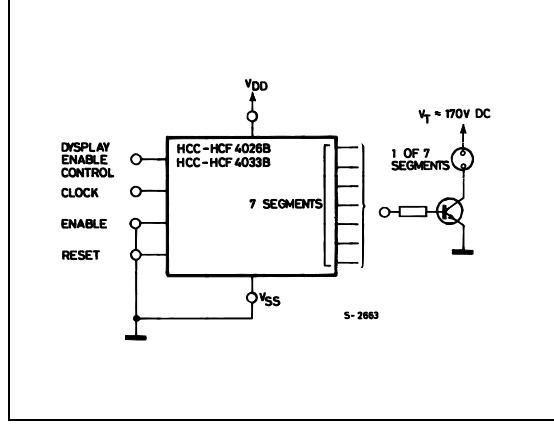
Interfacing with LED Displays (display common anode)

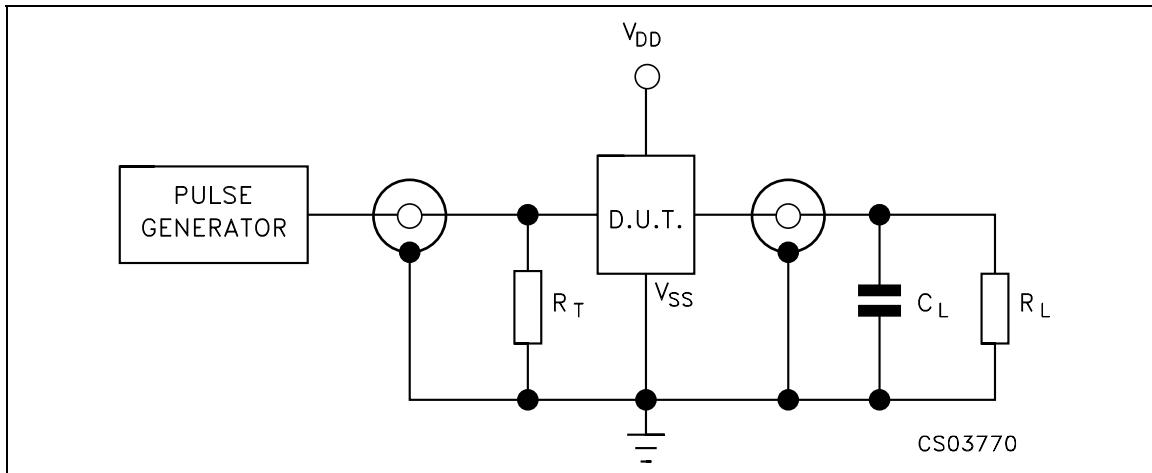


Interfacing with LED Displays (display common cathode)



Interfacing with NIXIE Tube



TEST CIRCUIT

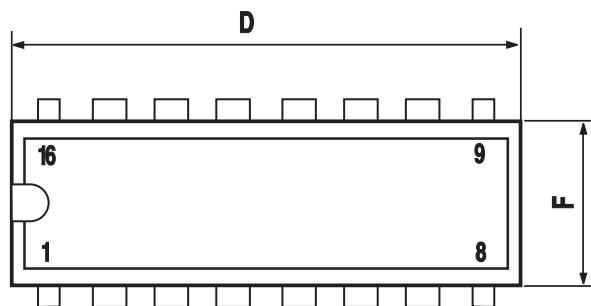
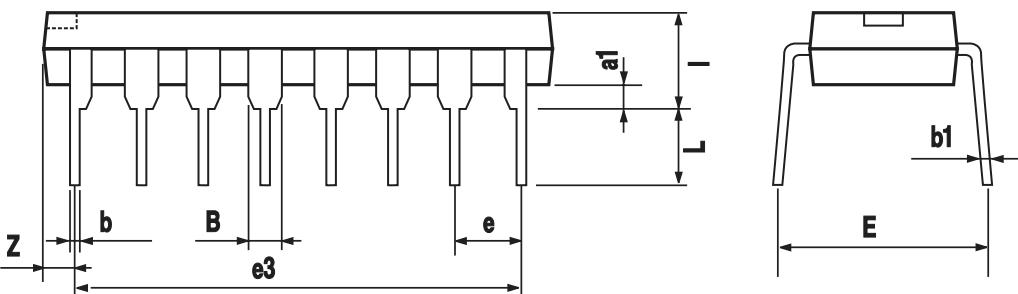
$C_L = 50\text{pF}$ or equivalent (includes jig and probe capacitance)

$R_L = 200\text{K}\Omega$

$R_T = Z_{\text{OUT}}$ of pulse generator (typically 50Ω)

Plastic DIP-16 (0.25) MECHANICAL DATA

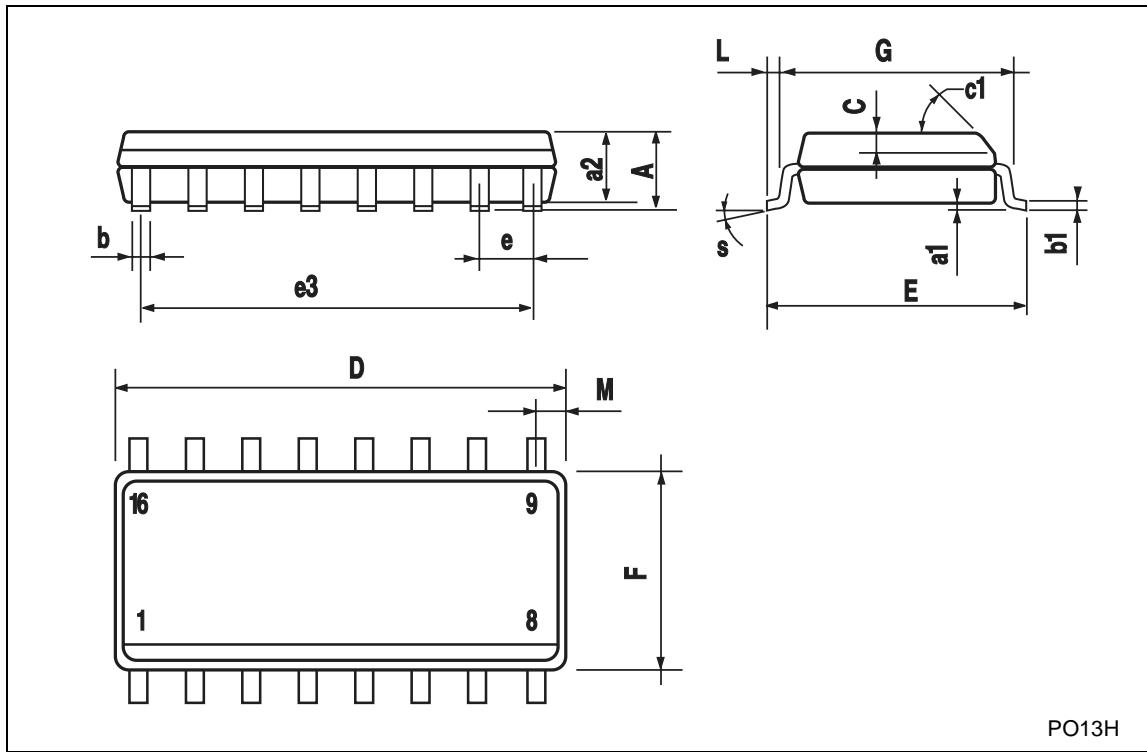
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	0.77		1.65	0.030		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		17.78			0.700	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z			1.27			0.050



P001C

SO-16 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.003		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1			45° (typ.)			
D	9.8		10	0.385		0.393
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		8.89			0.350	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.62			0.024
S			8° (max.)			



PO13H

Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

© The ST logo is a registered trademark of STMicroelectronics

© 2001 STMicroelectronics - Printed in Italy - All Rights Reserved
STMicroelectronics GROUP OF COMPANIES

Australia - Brazil - China - Finland - France - Germany - Hong Kong - India - Italy - Japan - Malaysia - Malta - Morocco
Singapore - Spain - Sweden - Switzerland - United Kingdom

© <http://www.st.com>

